Integrated Relay, Inductive Load Driver

This device is used to switch inductive loads such as relays, solenoids incandescent lamps, and small DC motors without the need of a free—wheeling diode. The device integrates all necessary items such as the MOSFET switch, ESD protection, and Zener clamps. It accepts logic level inputs thus allowing it to be driven by a large variety of devices including logic gates, inverters, and microcontrollers.

Features

- Provides a Robust Driver Interface Between DC Relay Coil and Sensitive Logic Circuits
- Optimized to Switch Relays from 3.0 V to 5.0 V Rail
- Capable of Driving Relay Coils Rated up to 2.5 W at 5.0 V
- Internal Zener Eliminates the Need of Free–Wheeling Diode
- Internal Zener Clamp Routes Induced Current to Ground for Quieter Systems Operation
- Low V_{DS(ON)} Reduces System Current Drain
- Pb-Free Package is Available

Typical Applications

- Telecom: Line Cards, Modems, Answering Machines, FAX
- Computers and Office: Photocopiers, Printers, Desktop Computers
- Consumer: TVs and VCRs, Stereo Receivers, CD Players, Cassette Recorders
- Industrial:Small Appliances, Security Systems, Automated Test Equipment, Garage Door Openers
- Automotive: 5.0 V Driven Relays, Motor Controls, Power Latches, Lamp Drivers



ON Semiconductor®

http://onsemi.com

RELAY/INDUCTIVE
LOAD DRIVER
SILICON SMALLBLOCK™
0.5 Ampere, 8.0 V Clamp

MARKING DIAGRAM

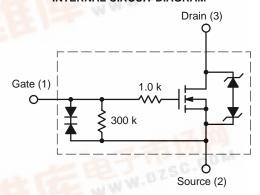


SOT-23 TO-236 CASE 318



JW4 = Specific Device Code D = Date Code

INTERNAL CIRCUIT DIAGRAM



ORDERING INFORMATION

Device	Package	Shipping [†]
NUD3105LT1	SOT-23	3000 Units/Reel
NUD3105LT1G	SOT-23 (Pb-Free)	3000 Units/Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.



MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise specified)

Symbol	Rating	Value	Unit
V _{DSS}	Drain to Source Voltage – Continuous	6.0	V _{dc}
V_{GS}	Gate to Source Voltage – Continuous	6.0	V _{dc}
I _D	Drain Current – Continuous	500	mA
E _z	Single Pulse Drain-to-Source Avalanche Energy (T _{Jinitial} = 25°C) (Note 2)	50	mJ
E _{zpk}	Repetitive Pulse Zener Energy Limit (DC ≤ 0.01%) (f = 100 Hz, DC = 0.5)	4.5	mJ
T_J	Junction Temperature	150	°C
T _A	Operating Ambient Temperature	-40 to 85	°C
T _{stg}	Storage Temperature Range	-65 to +150	°C
P _D	Total Power Dissipation (Note 1) Derating Above 25°C	225 1.8	mW mW/°C
$R_{\theta JA}$	Thermal Resistance Junction–to–Ambient	556	°C/W

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied,

2. Refer to the section covering Avalanche and Energy.

Symbol	Characteristic	Min	Тур	Max	Unit
OFF CHAR	ACTERISTICS				
V _{BRDSS}	Drain to Source Sustaining Voltage (Internally Clamped) (ID = 10 mA)	6.0	8.0	9.0	V
B _{VGSO}	I _g = 1.0 mA	_	-	8.0	V
I _{DSS}	Drain to Source Leakage Current $ (V_{DS} = 5.5 \text{ V} , V_{GS} = 0 \text{ V}, T_J = 25^{\circ}\text{C}) $ $ (V_{DS} = 5.5 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 85^{\circ}\text{C}) $		- -	15 15	μΑ
I _{GSS}	Gate Body Leakage Current $(V_{GS} = 3.0 \text{ V}, V_{DS} = 0 \text{ V})$ $(V_{GS} = 5.0 \text{ V}, V_{DS} = 0 \text{ V})$	5.0	_ _	19 50	μΑ
ON CHARA	CTERISTICS				
V _{GS(th)}	Gate Threshold Voltage $ (V_{GS} = V_{DS}, I_D = 1.0 \text{ mA}) $ $ (V_{GS} = V_{DS}, I_D = 1.0 \text{ mA}, T_J = 85^{\circ}\text{C}) $	0.8 0.8	1.2 -	1.4 1.4	V
R _{DS(on)}	Drain to Source On–Resistance $ \begin{array}{l} (I_D=250 \text{ mA}, \text{ V}_{GS}=3.0 \text{ V}) \\ (I_D=500 \text{ mA}, \text{ V}_{GS}=3.0 \text{ V}) \\ (I_D=500 \text{ mA}, \text{ V}_{GS}=3.0 \text{ V}) \\ (I_D=500 \text{ mA}, \text{ V}_{GS}=5.0 \text{ V}) \\ (I_D=500 \text{ mA}, \text{ V}_{GS}=3.0 \text{ V}, \text{ T}_J=85^{\circ}\text{C}) \\ (I_D=500 \text{ mA}, \text{ V}_{GS}=5.0 \text{ V}, \text{ T}_J=85^{\circ}\text{C}) \end{array} $	- - - -	- - - -	1.2 1.3 0.9 1.3 0.9	Ω
I _{DS(on)}	Output Continuous Current $ (V_{DS} = 0.25 \text{ V}, V_{GS} = 3.0 \text{ V}) \\ (V_{DS} = 0.25 \text{ V}, V_{GS} = 3.0 \text{ V}, T_{J} = 85^{\circ}\text{C}) $	300 200	400 -	- -	mA
9FS	Forward Transconductance (V _{OUT} = 5.0 V, I _{OUT} = 0.25 A)	350	570	-	mmhos
DYNAMIC (CHARACTERISTICS	<u>.</u>			
C _{iss}	Input Capacitance (V _{DS} = 5.0 V,V _{GS} = 0 V, f = 10 kHz)	-	25	-	pF

damage may occur and reliability may be affected.

1. This device contains ESD protection and exceeds the following tests:

Human Body Model 2000 V per MIL_STD-883, Method 3015.

Machine Model Method 200 V.

TYPICAL ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Characteristic		Тур	Max	Unit
DYNAMIC CHARACTERISTICS					
C _{oss}	Output Capacitance $(V_{DS} = 5.0 \text{ V}, V_{GS} = 0 \text{ V}, f = 10 \text{ kHz})$	-	37	-	pF
C _{rss}	Transfer Capacitance $(V_{DS} = 5.0 \text{ V}, V_{GS} = 0 \text{ V}, f = 10 \text{ kHz})$	_	8.0	-	pF

SWITCHING CHARACTERISTICS

Symbol	Characteristic	Min	Тур	Max	Units
	Propagation Delay Times:				nS
t _{PHL}	High to Low Propagation Delay; Figure 1 (5.0 V)	_	25	_	
t _{PLH}	Low to High Propagation Delay; Figure 1 (5.0 V)	-	80	-	
t _{PHL}	High to Low Propagation Delay; Figure 1 (3.0 V)	_	44	_	
t _{PLH}	Low to High Propagation Delay; Figure 1 (3.0 V)	_	44	_	
	Transition Times:				nS
t _f	Fall Time; Figure 1 (5.0 V)	_	23	_	
t _r	Rise Time; Figure 1 (5.0 V)	-	32	-	
t _f	Fall Time; Figure 1 (3.0 V)	_	53	_	
t _r	Rise Time; Figure 1 (3.0 V)	_	30	_	_

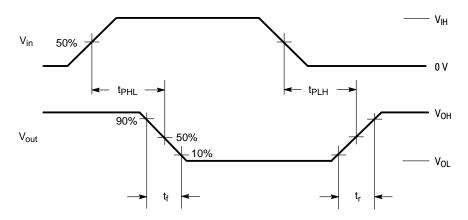


Figure 1. Switching Waveforms

http://opsomi.com

TYPICAL CHARACTERISTICS

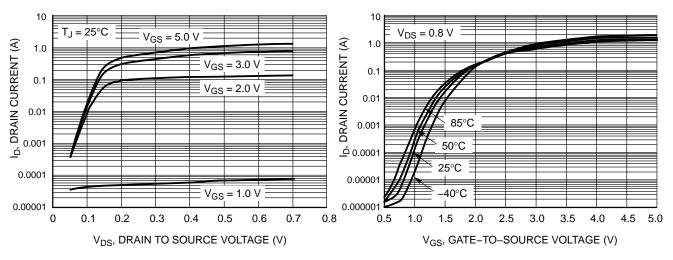


Figure 2. Output Characteristics

Figure 3. Transfer Function

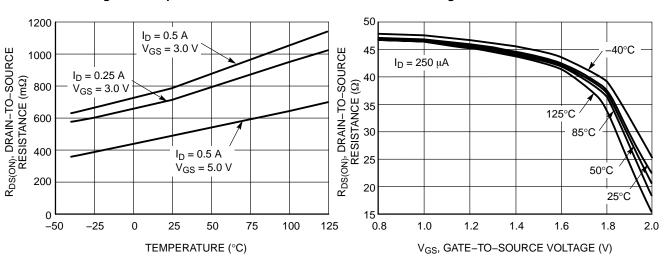


Figure 4. On Resistance Variation vs. Temperature

Figure 5. R_{DS(ON)} Variation with Gate-To-Source Voltage

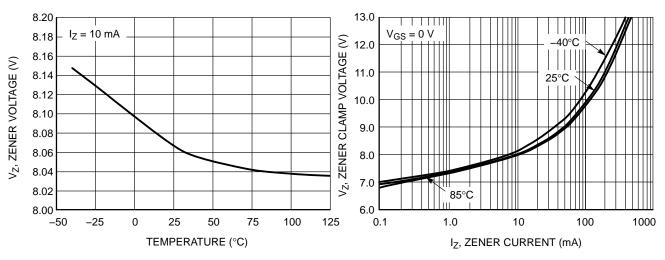


Figure 6. Zener Voltage vs. Temperature

Figure 7. Zener Clamp Voltage vs. Zener Current

TYPICAL CHARACTERISTICS

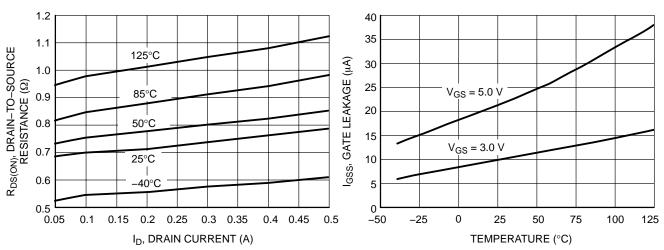


Figure 8. On–Resistance vs. Drain Current and Temperature

Figure 9. Gate Leakage vs. Temperature

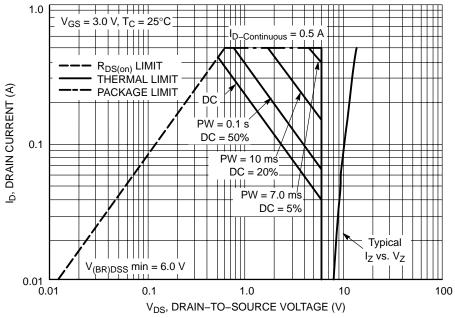


Figure 10. Safe Operating Area

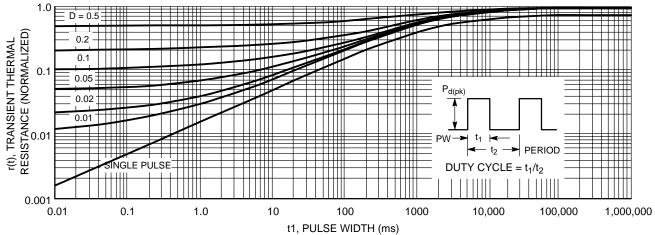


Figure 11. Transient Thermal Response

Designing with this Data Sheet

- Determine the maximum inductive load current (at max V_{CC}, min coil resistance & usually minimum temperature) that the NUD3105 will have to drive and make sure it is less than the max rated current.
- 2. For pulsed operation, use the Transient Thermal Response of Figure 11 and the instructions with it to determine the maximum limit on transistor power dissipation for the desired duty cycle and temperature range.
- 3. Use Figures 10 and 11 with the SOA notes to insure that instantaneous operation does not push the device beyond the limits of the SOA plot.

- Verify that the circuit driving the gate will meet the V_{GS(th)} from the Electrical Characteristics table.
- 5. Using the max output current calculated in step 1, check Figure 7 to insure that the range of Zener clamp voltage over temperature will satisfy all system & EMI requirements.
- 6. Use I_{GSS} and I_{DSS} from the Electrical Characteristics table to insure that "OFF" state leakage over temperature and voltage extremes does not violate any system requirements.
- 7. Review circuit operation and insure none of the device max ratings are being exceeded.

APPLICATIONS DIAGRAMS

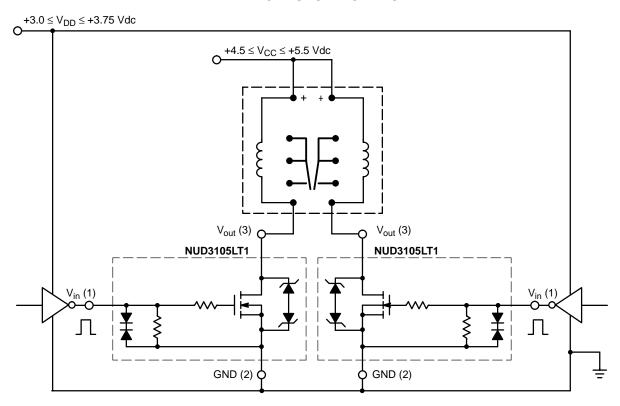


Figure 12. A 200 mW, 5.0 V Dual Coil Latching Relay Application with 3.0 V Level Translating Interface

http://opsami.com

Max Continuous Current Calculation

for TX2–5V Relay, R1 = 178 Ω Nominal @ R_A = 25°C

Assuming ±10% Make Tolerance,

R1 = 178 Ω * 0.9 = 160 Ω Min @ T_A = 25°C

 T_{C} for Annealed Copper Wire is $0.4\%/^{\circ}C$

R1 = 160 Ω * [1+(0.004) * (-40°-25°)] = 118 Ω Min @ -40°C

 I_O Max = (5.5 V Max – 0.25V) /118 Ω = 45 mA

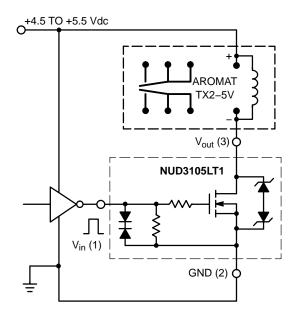


Figure 13. A 140 mW, 5.0 V Relay with TTL Interface

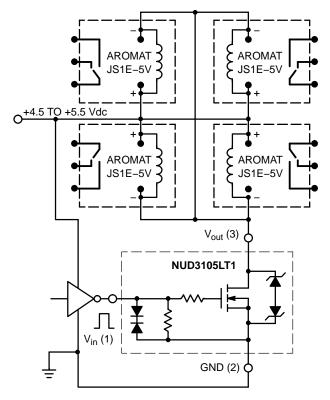
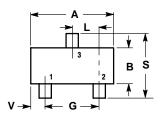
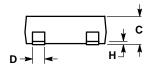


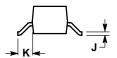
Figure 14. A Quad 5.0 V, 360 mW Coil Relay Bank

PACKAGE DIMENSIONS

SOT-23 (TO-236) CASE 318-08 ISSUE AK







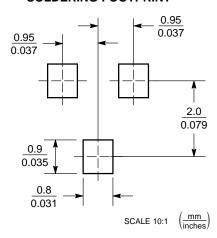
- 1. DIMENSIONING AND TOLERANCING PER ANSI
- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF
- BASE MATERIAL. 318-03 AND -07 OBSOLETE, NEW STANDARD

	INC	HES	MILLIN	IETERS			
DIM	MIN	MAX	MIN	MAX			
Α	0.1102	0.1197	2.80	3.04			
В	0.0472	0.0551	1.20	1.40			
С	0.0350	0.0440	0.89	1.11			
D	0.0150	0.0200	0.37	0.50			
G	0.0701	0.0807	1.78	2.04			
Н	0.0005	0.0040	0.013	0.100			
J	0.0034	0.0070	0.085	0.177			
K	0.0140	0.0285	0.35	0.69			
L	0.0350	0.0401	0.89	1.02			
S	0.0830	0.1039	2.10	2.64			
V	0.0177	0.0236	0.45	0.60			

STYLE 21:

- PIN 1. GATE
 - 2. SOURCE
 - DRAIN

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

SMALLBLOCK is a trademark of Semiconductor Components Industries, LLC (SCILLC).

ON Semiconductor and are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 61312, Phoenix, Arizona 85082-1312 USA **Phone**: 480–829–7710 or 800–344–3860 Toll Free USA/Canada **Fax**: 480–829–7709 or 800–344–3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free

Japan: ON Semiconductor, Japan Customer Focus Center 2-9-1 Kamimeguro, Meguro-ku, Tokyo, Japan 153-0051 Phone: 81-3-5773-3850

ON Semiconductor Website: http://onsemi.com

Order Literature: http://www.onsemi.com/litorder

For additional information, please contact your local Sales Representative.